

Notice of References Cited	Application/Control No. 10/773,315	Applicant(s)/Patent Under Reexamination KURODA ET AL.	
	Examiner Hai L. Nguyen	Art Unit 2816	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	A	US-6,430,725 B1	08-2002	Reichle et al.	714/815
X	B	US-6,356,096 B2	03-2002	Takagi et al.	324/765
X	C	US-6,081,462	06-2000	Lee, Terry R.	365/194
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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